

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/657,039	TOBEY, CHRIS	TOPHER LEE
Examiner	Art Unit	
Carolyn M. Bleck	3626	

	SEARCHED					
Class	Subclass	Date	Examiner			
705 US only	7-9	6/13/05	CB			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East search-uspat, USpgpbjepo,jpo, derwent, ibm-tdb- sleattached printout For search	6/13/05	CB